Compliant with IEC 62474/ D9.00

MICROCHIP				Pattern (Graphic)			Package Homogeneous Materials: 8.1 Electronics (e.g. pc boards, displays)			
Semiconductor Device Type:	GL	(EUX) 025 1.97x1.97x0.57 WLCSP SAC		••••	•					e1
		"Contained In"	% I otal							
Basic Substance	CAS Number	Sub-Component	Weight	mg/part	ppm	0.69	(mg) Total	Backside Coating	% of Total Weight	7.35
Silica	Proprietary	Backside Coating	4.153	0.392	41,528		Silica	Proprietary	56.50	
Epoxy Resin	Proprietary	Backside Coating	1.551	0.147	15,509		Epoxy Resin	Proprietary	21.10	
Acrylic Resin	Proprietary	Backside Coating	1.551	0.147	15,509		Acrylic Resin	Proprietary	21.10	
Carbon Black	Proprietary	Backside Coating	0.096	0.009	956		Carbon Black	Proprietary	1.30	
Organosilicate polymer	Trade Secret	PBO Layer	1.230	0.116	12,300			Total	100.00	•
Copper	7440-50-8	Under Bump Metal	0.212	0.020	2,120	0.12	(mg) Total	PBO Layer	% of Total Weight	1.23
Aluminum	7429-90-5	Under Bump Metal	0.077	0.007	774		Organosilicate polymer	Trade Secret	100.00	
Nickel	7440-02-0	Under Bump Metal	0.042	0.004	421			Total	100.00	1
Vanadium	7440-62-2	Under Bump Metal	0.028	0.003	284	0.03	(mg) Total	Under Bump Metal	% of Total Weight	0.36
Silicon	7440-21-3	Chip (Die)	76.390	7.219	763,900		Copper	7440-50-8	58.90	
Aluminum	7429-60-5	Redistribution Layer	0.152	0.014	1,522		Aluminum	7429-90-5	21.50	
Titanium	7440-32-6	Redistribution Layer	0.068	0.006	678		Nickel	7440-02-0	11.70	
Tin	7440-31-5	Solder Ball	13.944	1,318	139,443		Vanadium	7440-62-2	7.90	
Silver	7440-22-4	Solder Ball	0.434	0.041	4.335			Total	100.00	l
Copper	7440-50-8	Solder Ball	0.072	0.007	723	7.22	(mg) Total	Chip (Die)	% of Total Weight	76.39
*******		TOTALS:	100.000	9.450	1.000.000		Doped Silicon	7440-21-3	100.00	7 0.00
	0.00045	a Total Mass			.,,			Total		J
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SnAgCu 1:37 PM : 8/17/2015